

TECHNICAL SPECIFICATION



Nanomanufacturing – Key control characteristics –
Part 6-1: Graphene-based material – Volume resistivity: four probe method
ITeC STANDARD PREVIEW
(standards.iteh.ai)

[IEC TS 62607-6-1:2020](https://standards.iteh.ai/catalog/standards/sist/9ac99005-463d-4049-858c-3b5de871c313/iec-ts-62607-6-1-2020)

<https://standards.iteh.ai/catalog/standards/sist/9ac99005-463d-4049-858c-3b5de871c313/iec-ts-62607-6-1-2020>



THIS PUBLICATION IS COPYRIGHT PROTECTED
Copyright © 2020 IEC, Geneva, Switzerland

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from either IEC or IEC's member National Committee in the country of the requester. If you have any questions about IEC copyright or have an enquiry about obtaining additional rights to this publication, please contact the address below or your local IEC member National Committee for further information.

IEC Central Office
3, rue de Varembe
CH-1211 Geneva 20
Switzerland

Tel.: +41 22 919 02 11
info@iec.ch
www.iec.ch

About the IEC

The International Electrotechnical Commission (IEC) is the leading global organization that prepares and publishes International Standards for all electrical, electronic and related technologies.

About IEC publications

The technical content of IEC publications is kept under constant review by the IEC. Please make sure that you have the latest edition, a corrigendum or an amendment might have been published.

IEC publications search - webstore.iec.ch/advsearchform

The advanced search enables to find IEC publications by a variety of criteria (reference number, text, technical committee,...). It also gives information on projects, replaced and withdrawn publications.

IEC Just Published - webstore.iec.ch/justpublished

Stay up to date on all new IEC publications. Just Published details all new publications released. Available online and once a month by email.

IEC Customer Service Centre - webstore.iec.ch/csc

If you wish to give us your feedback on this publication or need further assistance, please contact the Customer Service Centre: sales@iec.ch.

Electropedia - www.electropedia.org

The world's leading online dictionary on electrotechnology, containing more than 22 000 terminological entries in English and French, with equivalent terms in 16 additional languages. Also known as the International Electrotechnical Vocabulary (IEV) online.

IEC Glossary - std.iec.ch/glossary

67 000 electrotechnical terminology entries in English and French extracted from the Terms and Definitions clause of IEC publications issued since 2002. Some entries have been collected from earlier publications of IEC TC 37, 77, 86 and CISPR.

[IEC TS 62607-6-1:2020](https://standards.iec.ch/catalog/standards/sis/9ac99005-463d-4049-858c-3b5de871c313/iec-ts-62607-6-1-2020)

<https://standards.iec.ch/catalog/standards/sis/9ac99005-463d-4049-858c-3b5de871c313/iec-ts-62607-6-1-2020>

TECHNICAL SPECIFICATION



Nanomanufacturing – Key control characteristics –
Part 6-1: Graphene-based material – Volume resistivity: four probe method

STANDARD PREVIEW
(standards.iteh.ai)

IEC TS 62607-6-1:2020
<https://standards.iteh.ai/catalog/standards/sist/9ac99005-463d-4049-858c-3b5de871c313/iec-ts-62607-6-1-2020>

INTERNATIONAL
ELECTROTECHNICAL
COMMISSION

ICS 07.120

ISBN 978-2-8322-8561-9

Warning! Make sure that you obtained this publication from an authorized distributor.

CONTENTS

FOREWORD.....	4
INTRODUCTION.....	6
1 Scope.....	7
2 Normative references	7
3 Terms and definitions	7
3.1 General terms	8
3.2 Key control characteristics	8
3.3 Terms related to measurements.....	8
4 Sample preparation	10
5 Measurement of volume resistivity of graphene pellet.....	10
5.1 Description of the measurement apparatus	10
5.2 Determination of sample amount.....	12
5.3 The measurement procedures.....	12
6 Data analysis and interpretation of results	12
6.1 General.....	12
6.2 Analysis of volume resistivity as a function of the applied pressures	13
6.3 Calculation of volume conductivity of a pellet.....	13
6.4 Analysis of volume resistivity (or volume conductivity) as a function of the volume density of graphene pellet.....	13
7 Report	14
Annex A (informative) Case studies	15
A.1 Graphene (reduced graphene oxide (rGO) and graphene nanopowder (GNP)).....	15
A.2 Morphology change of rGO flakes before and after pressurization.....	15
A.3 Raman spectroscopy measurement of graphene powder before and after pressurization up to 52 MPa.....	16
A.4 Results on powder resistivity measurements.....	17
A.4.1 Powder resistivity measurement of rGO-A (company 1) with various amounts	17
A.4.2 Powder resistivity measurement of 1,0 g of rGO-B (company 2).....	19
A.4.3 Powder resistivity measurement of GNP	22
A.4.4 Powder resistivity measurement of graphene oxides with different amounts of oxygen	26
Bibliography.....	32
Figure 1 – Measurement system	11
Figure A.1 – FE-SEM images of rGO flakes of (A) Company 1 (rGO-A), (B) Company 2 (rGO-B) and (C) graphene nanopowder (GNP) before (left) and after (right) pressurization	15
Figure A.2 – Raman spectra of (A) rGO-A, (B) rGO-B and (C) GNP before (black line) and after (red line) pressurization	16
Figure A.3 – Comparison data for I_D/I_G of rGO-A (short-dash line), rGO-B (solid line) and GNP (long-dash line) before and after pressurization	16
Figure A.4 – Correlation plots of (A) thickness, (B) volume resistivity (ρ_V), and (C) volume conductivity (σ_V) as a function of the applied pressure: (1) 0,1 g and (2) 0,2 g of rGO-A.....	18

Figure A.5 – Correlation plots of (A) volume resistivity (ρ_V) and (B) volume conductivity (σ_V) as a function of the volume density (d_V) of a graphene pellet: 0,1 g (filled symbol) and 0,2 g (unfilled symbol) of rGO-A	19
Figure A.6 – Correlation plots of (A) thickness (t), (B) volume resistivity (ρ_V), and (C) volume conductivity (σ_V) of rGO-B (1,0 g) as a function of the applied pressure	19
Figure A.7 – Correlation plots of (A) volume resistivity (ρ_V) and (B) volume conductivity (σ_V) of rGO-B (1,0 g) as a function of the volume density (d_V) of the graphene pellet	20
Figure A.8 – Correlation plots of (A) volume resistivity (ρ_V) and (B) volume conductivity (σ_V) as a function of the volume density (d_V) of graphene pellets: 0,1 g (filled symbol), 0,2 g (unfilled symbol) of rGO-A and 1,0 g (lined symbol) of rGO-B	20
Figure A.9 – Correlation plots of (A) thickness (t), (B) volume resistivity (ρ_V), and (C) volume conductivity (σ_V) as a function of the applied pressure: (1) 0,1 g and (2) 0,2 g of GNP.....	22
Figure A.10 – Correlation plots of (A) volume resistivity (ρ_V) and (B) volume conductivity (σ_V) as a function of the volume density (d_V) of a graphene pellet: 0,1 g (filled symbol) and 0,2 g (unfilled symbol) of GNP	23
Figure A.11 – Comparison plots of (A) volume resistivity (ρ_V) and (B) volume conductivity (σ_V) as a function of the volume density (d_V) of graphene pellets: rGO-A (filled symbol) and GNP (unfilled symbol).....	23
Figure A.12 – XPS survey spectra of as-received (A) rGO-A, (B) rGO-B and (C) GNP	24
Figure A.13 – Correlation plots of thickness (t) as a function of the applied pressure: 0,3 g samples of four types of graphene oxide (G-a, G-b, G-c, and G-d).....	26
Figure A.14 – Correlation plots of volume resistivity (ρ_V) as a function of the applied pressure: 0,3 g samples of four types of graphene oxide (G-a, G-b, G-c, and G-d)	27
Figure A.15 – Correlation plots of volume conductivity (σ_V) as a function of the applied pressure: 0,3 g samples of four types of graphene oxide (G-a, G-b, G-c, and G-d)	28
Figure A.16 – Correlation plots of volume resistivity (ρ_V) as a function of the volume density (d_V) of graphene oxide pellet (G-a, G-b, G-c, and G-d).....	29
Figure A.17 – Correlation plots of volume conductivity (σ_V) as a function of the volume density (d_V) of graphene oxide pellet (G-a, G-b, G-c, and G-d).....	30
Figure A.18 – Comparison plots of (A) volume resistivity (ρ_V) and (B) volume conductivity (σ_V) as a function of the volume density (d_V) of graphene oxide pellet (G-a, G-b, G-c, and G-d).....	30
Table 1 – Minimum thickness of the pellet vs amount of the used sample at the maximum applied pressure	12
Table A.1 – An example of the measurement parameters for rGO-A (0,2 g)	17
Table A.2 – Volume resistivity and volume conductivity of rGO pellets	21
Table A.3 – Volume resistivity and volume conductivity of GNP pellets	23
Table A.4 – Summary of XPS data of three graphene samples in a powder form.....	24
Table A.5 – Volume resistivity (ρ_V) and volume conductivity (σ_V) of graphene pellets	25
Table A.6 – Volume resistivity (ρ_V) and volume conductivity (σ_V) of four graphene oxide pellets.....	31

INTERNATIONAL ELECTROTECHNICAL COMMISSION

**NANOMANUFACTURING –
KEY CONTROL CHARACTERISTICS –****Part 6-1: Graphene-based material –
Volume resistivity: four probe method**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested IEC National Committees.
- 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.
- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
- 5) IEC itself does not provide any attestation of conformity. Independent certification bodies provide conformity assessment services and, in some areas, access to IEC marks of conformity. IEC is not responsible for any services carried out by independent certification bodies.
- 6) All users should ensure that they have the latest edition of this publication.
- 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC Publications.
- 8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.
- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

The main task of IEC technical committees is to prepare International Standards. In exceptional circumstances, a technical committee may propose the publication of a Technical Specification when

- the required support cannot be obtained for the publication of an International Standard, despite repeated efforts, or
- the subject is still under technical development or where, for any other reason, there is the future but no immediate possibility of an agreement on an International Standard.

Technical Specifications are subject to review within three years of publication to decide whether they can be transformed into International Standards.

IEC TS 62607-6-1, which is a Technical Specification, has been prepared by IEC technical committee 113: Nanotechnology for electrotechnical products and systems.

The text of this Technical Specification is based on the following documents:

Draft TS	Report on voting
113/454/DTS	113/511/RVDTS

Full information on the voting for the approval of this Technical Specification can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the IEC TS 62607 series, published under the general title *Nanomanufacturing – Key control characteristics*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

iTeh STANDARD PREVIEW

IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

IEC TS 62607-6-1:2020

<https://standards.iteh.ai/catalog/standards/sist/9ac99005-463d-4049-858c-3b5de871c313/iec-ts-62607-6-1-2020>

INTRODUCTION

Graphene has attracted great interest as a next generation electronic material due to its extremely high mobility and ballistic transport of electrons [1]¹. The unique properties of graphene enable it to be an effective candidate used in electronic products such as transparent conducting films, sensors, field emitters, supercapacitors, etc.

Characterization of the electrical properties of graphene itself is essential to both manufacturers and users in order to develop innovative electronic devices or to improve existing electronic devices using it.

Commercialized graphene products can be categorized by their manufacturing methods as follows: (i) graphene flakes and/or nanoplatelets in powder form (hereinafter called GNP), (ii) graphene sheets suspended in liquids or (iii) graphene films grown by chemical vapour deposition (CVD).

Many electrical properties of a powder-type graphene product are significantly affected by its geometric and electronic parameters [2]. First, it is required to select the parameter that best represents the quality of the graphene products. Second, a suitable sample preparation for the purpose of electrical measurements is also elucidated and described. Finally, measurement conditions are also crucial factors to determine the representative value of the powder product in terms of its electrical properties.

Among the measurands in determining electronic properties of powder-type graphene – sheet resistance (or conductance), resistivity (or conductivity), volume resistivity (or volume conductivity), and so on – this document selects volume resistivity (or volume conductivity) for the representative measurand which reveals the electrical properties of powder-type graphene through a series of experiments.

[IEC TS 62607-6-1:2020](https://standards.iteh.ai/catalog/standards/sist/9ac99005-463d-4049-858c-5126871e3794/iec-62607-6-1-2020)

<https://standards.iteh.ai/catalog/standards/sist/9ac99005-463d-4049-858c-5126871e3794/iec-62607-6-1-2020>

This document describes a simple method to evaluate the volume resistivity (or volume conductivity) of powder-type graphene, which includes preparation of its pellet and a measurement method.

Case studies illustrating the application of the standard are provided in Annex A.

¹ Numbers in square brackets refer to the Bibliography.

NANOMANUFACTURING – KEY CONTROL CHARACTERISTICS –

Part 6-1: Graphene-based material – Volume resistivity: four probe method

1 Scope

This part of IEC TS 62607 establishes a standardized method to determine the electrical key control characteristic

- volume resistivity
for powder consisting of graphene-based material like flakes of graphene, few layer graphene and/or reduced graphene oxide after preparation of a sample in pellet form by
- four probe method
using powder resistivity measurement system.

The volume resistivity is a measure of the quality of powder-type graphene products in terms of electrical property and reflects the density-dependency shown in a pellet of powder-type graphene.

The volume conductivity can directly be derived from the volume resistivity.

Typical application areas are industries that use powder-type graphene products for graphene manufacture, potential developers, and users who produce graphene-based products. As the volume resistivity measured according to this document requires the preparation of a sample in the form of a pellet, this document describes in detail

- an apparatus to prepare consistently a test sample, the pellet,
- the preparation of the pellet starting from powder-type graphene,
- the measurement procedure to measure the volume resistivity (or volume conductivity) of the pellet, and
- the data analysis, the interpretation and reporting of the results.

2 Normative references

There are no normative references in this document.

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia: available at <http://www.electropedia.org/>
- ISO Online browsing platform: available at <http://www.iso.org/obp>

NOTE A comprehensive nanotechnology vocabulary is under ongoing development in IEC TC 113 and ISO/TC 229, in cooperation with ISO/TC 229. The vocabulary is being published as different parts of IEC TS 80004 and ISO/TS 80004. The terms and definitions in this document are harmonized with the terms and definitions of IEC 80004 (all parts) and ISO 80004 (all parts). They will remain harmonized during the maintenance of the document. Definitions not yet specified are taken from scientific literature.

3.1 General terms

3.1.1

graphene pellet

disc formed by compression of graphene powder

3.1.2

reduced graphene oxide

rGO

reduced oxygen content form of graphene oxide

Note 1 to entry This can be produced by chemical, thermal, microwave, photo-chemical, photo-thermal or microbial/bacterial methods or by exfoliating reduced graphite oxide.

Note 2 to entry: If graphene oxide was fully reduced then graphene would be the product. However, in practice, some oxygen containing functional groups will remain and not all sp^3 bonds will return back to sp^2 configuration. Different reducing agents will lead to different carbon to oxygen ratios and different chemical compositions in reduced graphene oxide.

[SOURCE: ISO/TS 80004-13:2017 [3], 3.1.2.14]

3.1.3

graphene-based material

GBM

graphene material

grouping of carbon-based 2D materials that include one or more of graphene, bilayer graphene, few-layer graphene, graphene nanoplate, and functionalized variations thereof as well as graphene oxide and reduced graphene oxide

Note 1 to entry: "Graphene material" is a short name for graphene-based material.

3.2 Key control characteristics

3.2.1

volume resistivity

<of pellet formed from graphene-based material> key control characteristic to describe the quality of powder-type graphene products

Note 1 to entry The measured volume resistivity of powder-type graphene products mainly depends on geometric factors such as flake size and layer numbers of a flake. As the applied pressure into a pellet increases, electrical contact among flakes is improved. The measurand "volume resistivity" reflects the density-dependency shown in a pellet of powder-type graphene-based material.

3.3 Terms related to measurements

3.3.1

volume conductivity

electrical conductivity

conductivity

σ

characteristic physical property of three-dimensional materials describing the ability to conduct electric current

Note 1 to entry The volume conductivity is defined by Ohm's law, $j = \sigma \times E$, where j is the current density measured in amperes per square metre (A/m^2) and E the electric field in volts per metre (V/m).

Note 2 to entry The volume conductivity can be obtained by dividing the surface conductance by the conductor thickness (t): $\sigma = \sigma_s/t$. The unit of measure of σ is siemens per metre (S/m).

[SOURCE: IEC TS 62607-6-4:2016, 3.2.3]

3.3.2**volume resistivity**

electrical resistivity

resistivity

 ρ

reciprocal of the volume conductivity

Note 1 to entry The volume resistivity is defined by Ohm's law, $j = \rho^{-1} \times E$, where j is the current density measured in amperes per square metre (A/m²) and E the electric field in volts per metre (V/m).

Note 2 to entry The volume resistivity can be obtained by multiplying the surface resistance (ρ_s) by the conductor thickness (t): $\rho = \rho_s \times t$. The SI unit of ρ is the ohm metre ($\Omega \cdot m$).

3.3.3**surface conductance**

sheet conductance

 σ_s

characteristic physical property of two-dimensional materials describing the ability to conduct electric current

Note 1 to entry The SI unit of measure of σ_s is siemens (S). In the trade and industrial literature, however, siemens per square (S/square) is commonly used when referring to surface conductance. This is to avoid confusion between surface conductance and electric conductance (G), which share the same unit of measure:

$$G = IU = \sigma_s (w/l).$$

Note 2 to entry The surface conductance (σ_s) can be obtained by normalizing conductance G to the specimen width (w) and length (l).

iTeh STANDARD PREVIEW
(standards.iteh.ai)

[SOURCE: IEC TS 62607-6-4:2016, 3.2.1]

[IEC TS 62607-6-1:2020](https://standards.iteh.ai/catalog/standards/sist/9ac99005-463d-4049-858c-3b5de871c313/iec-ts-62607-6-1-2020)

3.3.4**surface resistance**

sheet resistance

 ρ_s

reciprocal of surface conductance

<https://standards.iteh.ai/catalog/standards/sist/9ac99005-463d-4049-858c-3b5de871c313/iec-ts-62607-6-1-2020>

Note 1 to entry: ρ_s is a characteristic property of two-dimensional materials. The SI unit of measure of ρ_s is the ohm (Ω). In the trade and industrial literature, however, ohms per square (Ω /square) is commonly used when referring to surface resistance or sheet resistance.

[SOURCE: IEC TS 62607-6-4:2016, 3.2.4]

3.3.5**conductance**

electrical conductance

 G

reciprocal of the resistance

Note 1 to entry The conductance is defined by Ohm's law, $I = G \cdot U$, where I is the current through the conductor measured in amperes and U the potential difference along the conductor measured in volts.

Note 2 to entry The conductance is related to the material property conductivity σ by $G = A \times \sigma/L$, where A is the cross-section of the conductor in square metres and L its length in metres. The SI unit of G is siemens (S).

3.3.6**resistance**

electrical resistance

 R

ratio of the potential difference along a conductor and the current through the conductor

Note 1 to entry The resistance is defined by Ohm's law, $U = R \times I$, where I is the current through the conductor measured in amperes and U the potential difference along the conductor measured in volts.

Note 2 to entry The resistance is related to the material property resistivity ρ by $R = \rho \times L/A$, where A is the cross section of the conductor in square metres and L its length in metres. The SI unit of R is the ohm (Ω).

[SOURCE: ISO 15091:2012, 3.1]

3.3.7

four probe method

method to measure electrical sheet resistance, impedance or conductivity of thin films that uses separate pairs of current-carrying and voltage-sensing electrodes

Note 1 to entry The method is fast, repositionable and local.

[SOURCE: ISO/TS 80004-13:2017, 3.3.3.1, modified – The term "four-terminal sensing" has been deleted and the term "four point probe method" has been replaced by "four probe method".]

4 Sample preparation

For measurement of graphene powders using the four probe method, the sample should be prepared with uniform surface over a large area [4]. Two types of sample are suitable for this measurement: pellet or film. The sample shall be made in the form of a pellet because generating a uniform film from powder-type graphene is difficult due to its low solubility in any solvent.

iTeh STANDARD PREVIEW

Graphene powder obtained from commercial sources is pelletized after vacuum drying at 80 °C for 24 h in order to remove any remnant of water content in the sample.

5 Measurement of volume resistivity of graphene pellet

IEC TS 62607-6-1:2020

<https://standards.iteh.ai/catalog/standards/sist/62607-6-1-2020/iec-ts-62607-6-1-2020>
4049-858c-3b5de871c313/iec-ts-62607-6-1-2020

5.1 Description of the measurement apparatus

The powder resistivity measurement system consists of two components [5],[6]:

- 1) a pelletizer and electrode unit;
- 2) an electrical measurement system.

The details of the measurement system are shown in Figure 1.

A pelletizer is composed of a four-probe head, a piston, and a cylinder. The head of the piston and the inside of the cylinder are covered with a non-conducting material, zirconia, so that the specimen is electrically isolated from all sides. The pelletizer is electrically connected to a four-probe unit through a probe connector. The four-probe setup consists of four equally-spaced copper or gold rods with identical radius. The inner diameter of the cylinder is 20,4 mm, the probe spacing is 1,6 mm, and the diameter of each of the four electrodes is 1,4 mm. The applied pressure is measured by a pressure gauge with high precision for a maximum pressure of 52 MPa. A height gauge is used to measure the height of the piston at a given pressure. The height difference before and after pressurizing is referred to as the pellet thickness.